

Pinouts

Figure 1. 52-Pin PLCC (Top View)

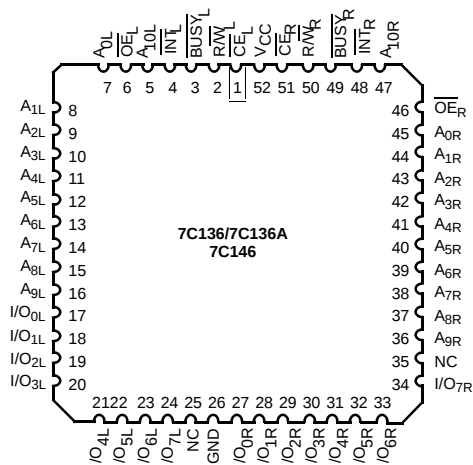
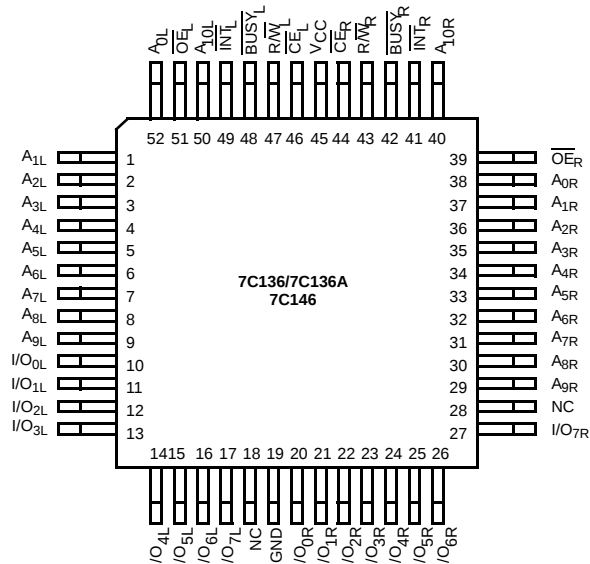


Figure 2. 52-Pin PQFP (Top View)



Selection Guide

Specification		7C136-15 ^[4] 7C146-15	7C132-25 ^[4] 7C136-25 7C142-25 7C146-25	7C132-30 7C136-30 7C142-30 7C146-30	7C132-35 7C136-35 7C142-35 7C146-35	7C132-45 7C136-45 7C142-45 7C146-45	7C132-55 7C136-55 7C136A-55 7C142-55 7C146-55	Unit
Maximum Access Time		15	25	30	35	45	55	ns
Maximum Operating Current	Com'I/Ind	190	170	170	120	120	110	mA
Maximum Standby Current	Com'I/Ind	75	65	65	45	45	35	mA

Shaded areas contain preliminary information.

Note:

4. 15 ns and 25 ns version available in PQFP and PLCC packages only.

Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

Storage temperature -65 °C to +150 °C

Ambient temperature with
Power Applied -55 °C to +125 °C

Supply voltage to ground potential
(Pin 48 to Pin 24) -0.5 V to +7.0 V

DC voltage applied to outputs
in High Z State -0.5 V to +7.0 V

DC input voltage -3.5 V to +7.0 V

Output current into outputs (LOW) 20 mA

Static discharge voltage > 2001 V
(per MIL-STD-883, Method 3015)

Latch up Current > 200 mA

Operating Range

Range	Ambient Temperature	V _{CC}
Commercial	0 °C to +70 °C	5 V ± 10%
Industrial	-40 °C to +85 °C	5 V ± 10%

Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditions	7C136-15 ^[4] 7C146-15		7C132-30 ^[4] 7C136-25, 30 7C142-30 7C146-25, 30		7C132-35,4 5 7C136-35,4 5 7C142-35,4 5 7C146-35,4 5		7C132-55 7C136-55 7C136A-55 7C142-55 7C146-55		Unit
			Min	Max	Min	Max	Min	Max	Min	Max	
V _{OH}	Output HIGH voltage	V _{CC} = Min, I _{OH} = -4.0 mA	2.4		2.4		2.4		2.4		V
V _{OL}	Output LOW voltage	I _{OL} = 4.0 mA		0.4		0.4		0.4		0.4	V
		I _{OL} = 16.0 mA ^[5]		0.5		0.5		0.5		0.5	
V _{IH}	Input HIGH voltage		2.2		2.2		2.2		2.2		V
V _{IL}	Input LOW voltage			0.8		0.8		0.8		0.8	V
I _{IX}	Input load current	GND ≤ V _I ≤ V _{CC}	-5	+5	-5	+5	-5	+5	-5	+5	μA
I _{OZ}	Output leakage current	GND ≤ V _O ≤ V _{CC} , Output Disabled	-5	+5	-5	+5	-5	+5	-5	+5	μA
I _{OS}	Output short circuit current ^[6]	V _{CC} = Max, V _{OUT} = GND		-350		-350		-350		-350	mA
I _{CC}	V _{CC} Operating Supply Current	$\overline{CE} = V_{IL}$, Outputs Open, f = f _{MAX} ^[7]		190		170		120		110	mA
I _{SB1}	Standby current both ports, TTL Inputs	$\overline{CE}_L$ and $\overline{CE}_R \geq V_{IH}$, f = f _{MAX} ^[7]		75		65		45		35	mA
I _{SB2}	Standby Current One Port, TTL Inputs	$\overline{CE}_L$ or $\overline{CE}_R \geq V_{IH}$, Active Port Outputs Open, f = f _{MAX} ^[7]		135		115		90		75	mA
I _{SB3}	Standby Current Both Ports, CMOS Inputs	Both Ports $\overline{CE}_L$ and $\overline{CE}_R \geq V_{CC} - 0.2$ V, V _{IN} ≥ V _{CC} - 0.2 V or V _{IN} ≤ 0.2 V, f = 0		15		15		15		15	mA
I _{SB4}	Standby Current One Port, CMOS Inputs	One Port $\overline{CE}_L$ or $\overline{CE}_R \geq V_{CC} - 0.2$ V, V _{IN} > V _{CC} - 0.2 V or V _{IN} < 0.2 V, Active Port Outputs Open, f = f _{MAX} ^[7]		125		105		85		70	mA

Notes

5. BUSY and INT pins only.

6. Duration of the short circuit should not exceed 30 seconds.

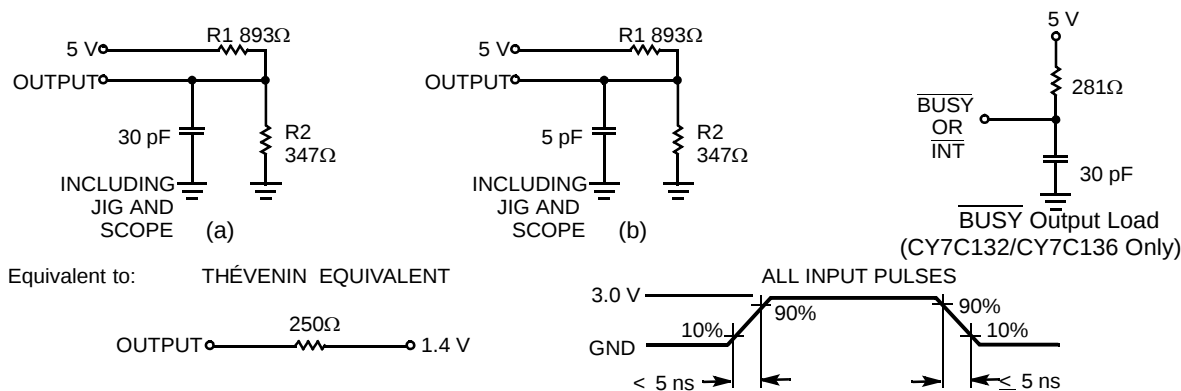
7. At f = f_{MAX}, address and data inputs are cycling at the maximum frequency of read cycle of 1/t_{rc} and using AC Test Waveforms input levels of GND to 3 V.

Capacitance

This parameter is guaranteed but not tested.

Parameter	Description	Test Conditions	Max	Unit
C_{IN}	Input Capacitance	$T_A = 25^\circ\text{C}$, $f = 1\text{ MHz}$, $V_{CC} = 5.0\text{ V}$	15	pF
C_{OUT}	Output Capacitance		10	pF

Figure 3. AC Test Loads and Waveforms



Switching Characteristics

Over the Operating Range (Speeds -15, -25, -30) ^[8]

Parameter	Description	7C136-15 ^[4] 7C146-15		7C132-25 ^[4] 7C136-25 7C142-25 7C146-25		7C132-30 7C136-30 7C142-30 7C146-30		Unit
		Min	Max	Min	Max	Min	Max	
Read Cycle								
t _{RC}	Read Cycle Time	15		25		30		ns
t _{AA}	Address to Data Valid ^[9]		15		25		30	ns
t _{OHA}	Data Hold from Address Change	0		0		0		ns
t _{ACE}	$\overline{\text{CE}}$ LOW to Data Valid ^[9]		15		25		30	ns
t _{DOE}	$\overline{\text{OE}}$ LOW to Data Valid ^[9]		10		15		20	ns
t _{LZOE}	$\overline{\text{OE}}$ LOW to Low Z ^[7, 10]	3		3		3		ns
t _{HZOE}	$\overline{\text{OE}}$ HIGH to High Z ^[7, 10, 11]		10		15		15	ns
t _{LZCE}	$\overline{\text{CE}}$ LOW to Low Z ^[7, 10]	3		5		5		ns
t _{HZCE}	$\overline{\text{CE}}$ HIGH to High Z ^[7, 10, 11]		10		15		15	ns
t _{PU}	$\overline{\text{CE}}$ LOW to power-up ^[7]	0		0		0		ns
t _{PD}	$\overline{\text{CE}}$ HIGH to power-down ^[7]		15		25		25	ns

Shaded areas contain preliminary information.

Notes

- Test conditions assume signal transition times of 5 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V and output loading of the specified I_{OL}/I_{OH} , and 30 pF load capacitance.
- AC test conditions use $V_{OH} = 1.6\text{ V}$ and $V_{OL} = 1.4\text{ V}$.
- At any given temperature and voltage condition for any given device, t_{HZCE} is less than t_{LZCE} and t_{HZOE} is less than t_{LZOE} .
- t_{LZCE} , t_{LZWE} , t_{HZOE} , t_{LZOE} , t_{HZCE} , and t_{HZWE} are tested with $C_L = 5\text{ pF}$ as in (b) of **AC Test Loads and Waveforms**. Transition is measured $\pm 500\text{ mV}$ from steady state voltage.

Switching Characteristics

Over the Operating Range (Speeds -15, -25, -30) ^[8] (continued)

Parameter	Description	7C136-15 ^[4] 7C146-15		7C132-25 ^[4] 7C136-25 7C142-25 7C146-25		7C132-30 7C136-30 7C142-30 7C146-30		Unit
		Min	Max	Min	Max	Min	Max	
Write Cycle ^[12]								
t _{WC}	Write Cycle Time	15		25		30		ns
t _{SCE}	CE LOW to Write End	12		20		25		ns
t _{AW}	Address Setup to Write End	12		20		25		ns
t _{HA}	Address Hold from Write End	2		2		2		ns
t _{SA}	Address Setup to Write Start	0		0		0		ns
t _{PWE}	R/W Pulse Width	12		15		25		ns
t _{SD}	Data Setup to Write End	10		15		15		ns
t _{HD}	Data Hold from Write End	0		0		0		ns
t _{HZWE}	R/W LOW to High Z ^[7]		10		15		15	ns
t _{LZWE}	R/W HIGH to Low Z ^[7]	0		0		0		ns
Busy/Interrupt Timing								
t _{BLA}	BUSY LOW from Address Match		15		20		20	ns
t _{BHA}	BUSY HIGH from Address Mismatch ^[13]		15		20		20	ns
t _{BLC}	BUSY LOW from CE LOW		15		20		20	ns
t _{BHC}	BUSY HIGH from CE HIGH ^[13]		15		20		20	ns
t _{PS}	Port Set Up for Priority	5		5		5		ns
t _{WB}	R/W LOW after BUSY LOW ^[14]	0		0		0		ns
t _{WH}	R/W HIGH after BUSY HIGH	13		20		30		ns
t _{BDD}	BUSY HIGH to Valid Data		15		25		30	ns
t _{DDD}	Write Data Valid to Read Data Valid		Note 15		Note 15		Note 15	ns
t _{WDD}	Write Pulse to Data Delay		Note 15		Note 15		Note 15	ns
Interrupt Timing ^[16]								
t _{WINS}	R/W to INTERRUPT Set Time		15		25		25	ns
t _{EINS}	CE to INTERRUPT Set Time		15		25		25	ns
t _{INS}	Address to INTERRUPT Set Time		15		25		25	ns
t _{OINR}	OE to INTERRUPT Reset Time ^[13]		15		25		25	ns
t _{EINR}	CE to INTERRUPT Reset Time ^[13]		15		25		25	ns
t _{INR}	Address to INTERRUPT Reset Time ^[13]		15		25		25	ns

Shaded areas contain preliminary information.

Notes

12. The internal write time of the memory is defined by the overlap of CE LOW and R/W LOW. Both signals must be LOW to initiate a write and either signal can terminate a write by going HIGH. The data input setup and hold timing must be referenced to the rising edge of the signal that terminates the write.

13. These parameters are measured from the input signal changing, until the output pin goes to a high impedance state.

14. CY7C142/CY7C146 only.

15. A write operation on Port A, where Port A has priority, leaves the data on Port B's outputs undisturbed until one access time after one of the following:

BUSY on Port B goes HIGH.

Port B's address toggled.

CE for Port B is toggled.

R/W for Port B is toggled during valid read.

16. 52-pin PLCC and PQFP versions only.

Switching Characteristics

Over the Operating Range (Speeds -35, -45, -55) ^[8]

Parameter	Description	7C132-35 7C136-35 7C142-35 7C146-35		7C132-45 7C136-45 7C142-45 7C146-45		7C132-55 7C136-55 7C136A-55 7C142-55 7C146-55		Unit
		Min	Max	Min	Max	Min	Max	
Read Cycle								
t _{RC}	Read Cycle Time	35		45		55		ns
t _{AA}	Address to Data Valid ^[9]		35		45		55	ns
t _{OHA}	Data Hold from Address Change	0		0		0		ns
t _{ACE}	CE LOW to Data Valid ^[9]		35		45		55	ns
t _{DOE}	OE LOW to Data Valid ^[9]		20		25		25	ns
t _{LZOE}	OE LOW to Low Z ^[7, 10]	3		3		3		ns
t _{HZOE}	OE HIGH to High Z ^[7, 10, 11]		20		20		25	ns
t _{LZCE}	CE LOW to Low Z ^[7, 10]	5		5		5		ns
t _{HZCE}	CE HIGH to High Z ^[7, 10, 11]		20		20		25	ns
t _{PU}	CE LOW to power-up ^[7]	0		0		0		ns
t _{PD}	CE HIGH to power-down ^[7]		35		35		35	ns
Write Cycle ^[12]								
t _{WC}	Write Cycle Time	35		45		55		ns
t _{SCE}	CE LOW to Write End	30		35		40		ns
t _{AW}	Address Setup to Write End	30		35		40		ns
t _{HA}	Address Hold from Write End	2		2		2		ns
t _{SA}	Address Setup to Write Start	0		0		0		ns
t _{PWE}	R/W Pulse Width	25		30		30		ns
t _{SD}	Data Setup to Write End	15		20		20		ns
t _{HD}	Data Hold from Write End	0		0		0		ns
t _{HZWE}	R/W LOW to High Z ^[7]		20		20		25	ns
t _{LZWE}	R/W HIGH to Low Z ^[7]	0		0		0		ns
Busy/Interrupt Timing								
t _{BLA}	BUSY LOW from Address Match		20		25		30	ns
t _{BHA}	BUSY HIGH from Address Mismatch ^[13]		20		25		30	ns
t _{BLC}	BUSY LOW from CE LOW		20		25		30	ns
t _{BHC}	BUSY HIGH from CE HIGH ^[13]		20		25		30	ns
t _{PS}	Port Set Up for Priority	5		5		5		ns
t _{WB}	R/W LOW after BUSY LOW ^[14]	0		0		0		ns
t _{WH}	R/W HIGH after BUSY HIGH	30		35		35		ns
t _{BDD}	BUSY HIGH to Valid Data		35		45		45	ns
t _{DDD}	Write Data Valid to Read Data Valid		Note 15		Note 15		Note 15	ns
t _{WDD}	Write Pulse to Data Delay		Note 15		Note 15		Note 15	ns

Switching Characteristics

Over the Operating Range (Speeds -35, -45, -55) ^[8] (continued)

Parameter	Description	7C132-35 7C136-35 7C142-35 7C146-35		7C132-45 7C136-45 7C142-45 7C146-45		7C132-55 7C136-55 7C136A-55 7C142-55 7C146-55		Unit
		Min	Max	Min	Max	Min	Max	
		Interrupt Timing ^[16]						
t _{WINS}	R/W to <u>INTERRUPT</u> Set Time		25		35		45	ns
t _{EINS}	<u>CE</u> to <u>INTERRUPT</u> Set Time		25		35		45	ns
t _{INS}	Address to <u>INTERRUPT</u> Set Time		25		35		45	ns
t _{OINR}	<u>OE</u> to <u>INTERRUPT</u> Reset Time ^[13]		25		35		45	ns
t _{EINR}	<u>CE</u> to <u>INTERRUPT</u> Reset Time ^[13]		25		35		45	ns
t _{INR}	Address to <u>INTERRUPT</u> Reset Time ^[13]		25		35		45	ns

Switching Waveforms

Figure 4. Read Cycle No. 1 (Either Port-Address Access) ^[17, 18]

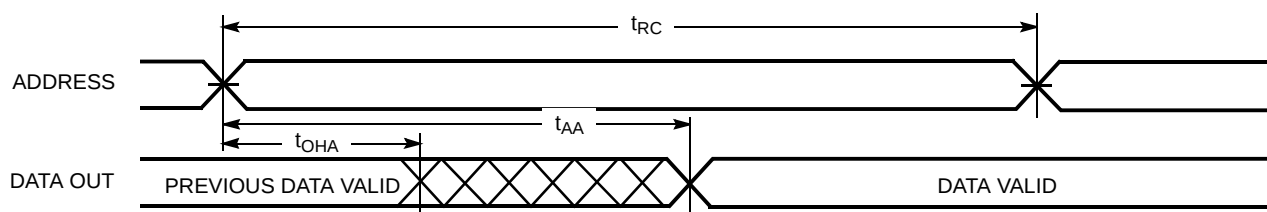
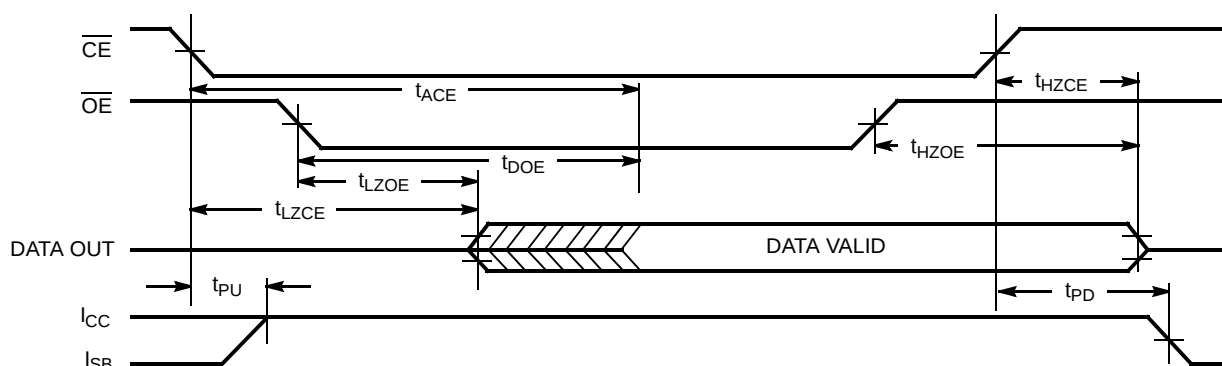


Figure 5. Read Cycle No. 2 (Either Port- $\overline{CE}/\overline{OE}$) ^[17, 19]



Notes

17. R/W is HIGH for read cycle.
18. Device is continuously selected, $\overline{CE} = V_{IL}$ and $\overline{OE} = V_{IL}$.
19. Address valid prior to or coincident with CE transition LOW.

Switching Waveforms (continued)

Figure 6. Read Cycle No. 3 (Read with $\overline{\text{BUSY}}$ Master: CY7C132 and CY7C136/CY7C136A)

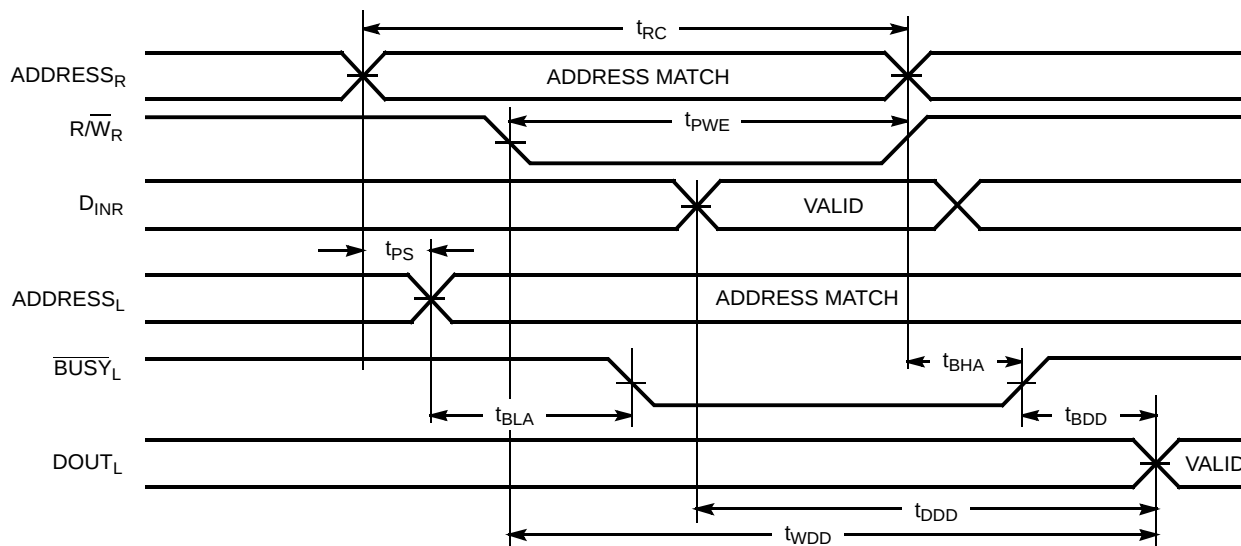
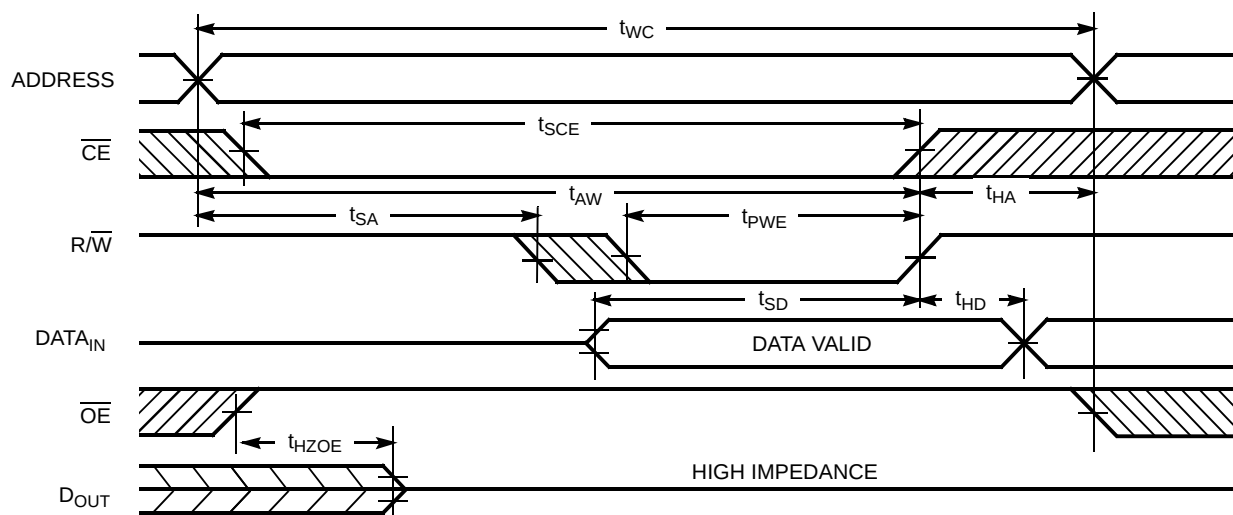


Figure 7. Write Cycle No.1 ($\overline{\text{OE}}$ Three-States Data I/Os—Either Port) [12, 20]



Note

20. If $\overline{\text{OE}}$ is LOW during a $\text{R}/\overline{\text{W}}$ controlled write cycle, the write pulse width must be the larger of t_{PWE} or $t_{\text{HZOE}} + t_{\text{SD}}$ to allow the data I/O pins to enter high impedance and for data to be placed on the bus for the required t_{SD} .

Switching Waveforms (continued)

Figure 8. Write Cycle No. 2 (R/W Three-States Data I/Os—Either Port)^[12, 21]

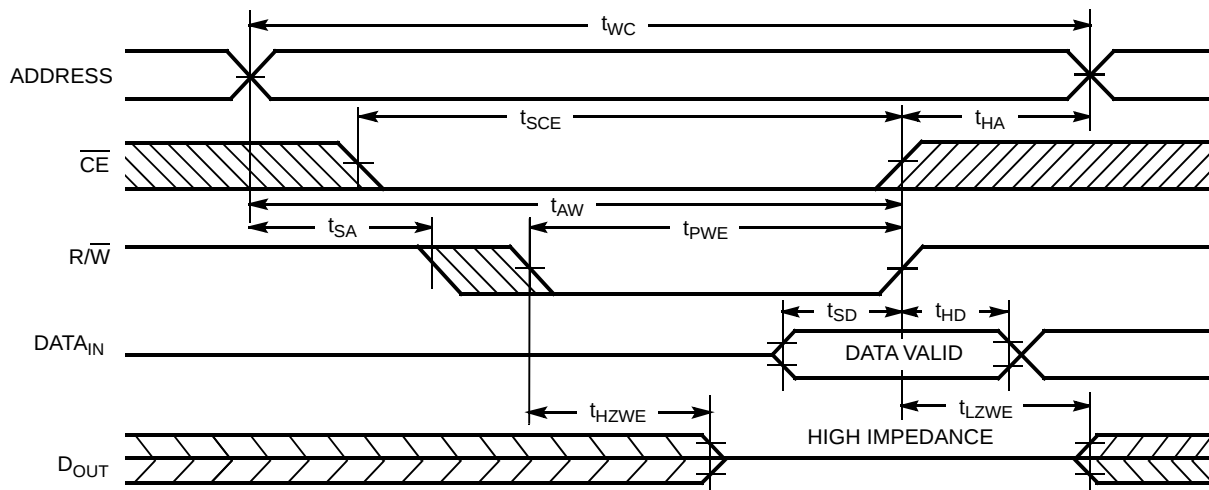
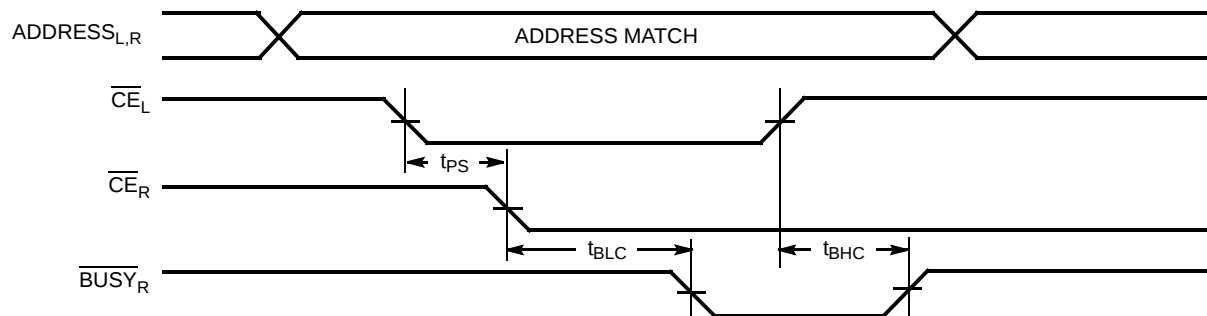
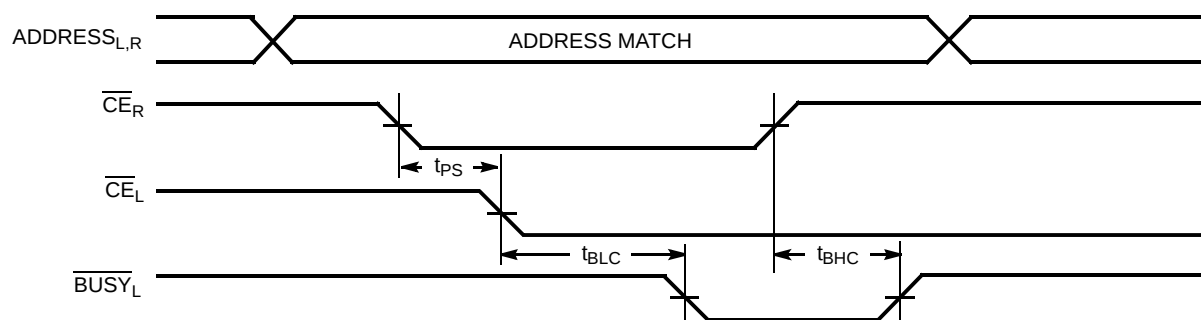


Figure 9. Busy Timing Diagram No. 1 ($\overline{CE}$ Arbitration)

$\overline{CE}_L$ Valid First:



$\overline{CE}_R$ Valid First:



Note

21. If the $\overline{CE}$ LOW transition occurs simultaneously with or after the R/W LOW transition, the outputs remain in a high impedance state.

Switching Waveforms (continued)

Figure 10. Busy Timing Diagram No. 2 (Address Arbitration)

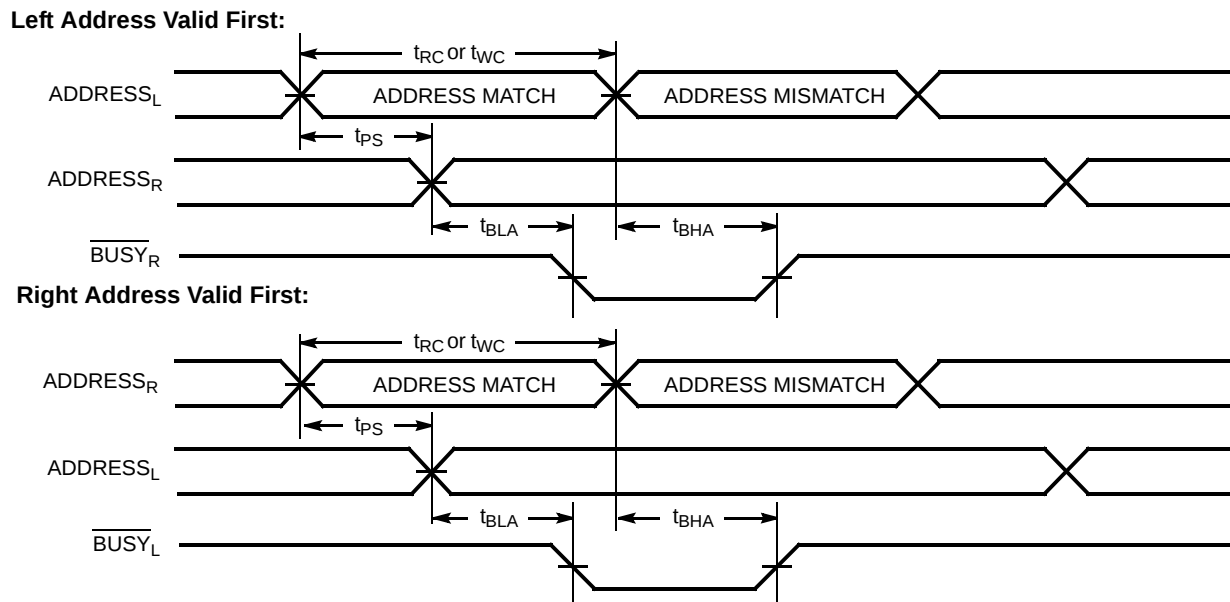
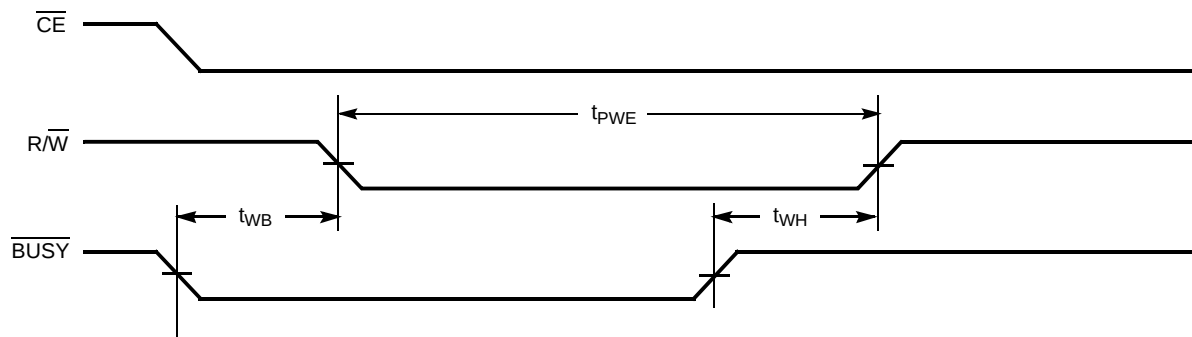


Figure 11. Busy Timing Diagram No. 3 (Write with $\overline{\text{BUSY}}$, Slave: CY7C142/CY7C146)



Switching Waveforms (continued)

Interrupt Timing Diagrams ^[16]

Figure 12. Left Side Sets $\overline{\text{INT}}_R$

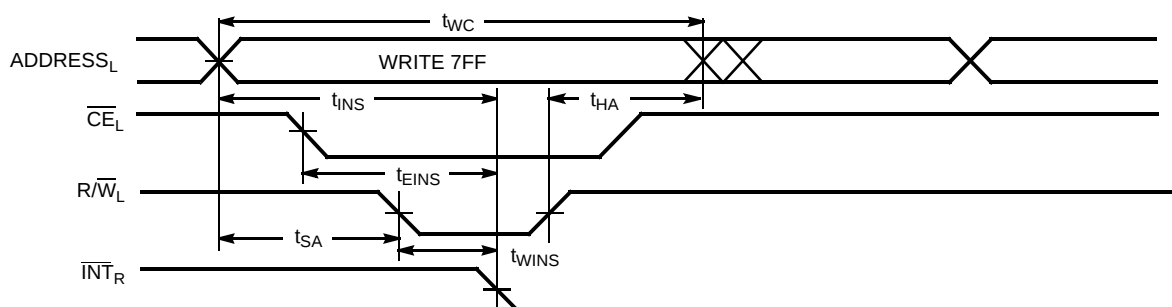


Figure 13. Right Side Clears $\overline{\text{INT}}_R$

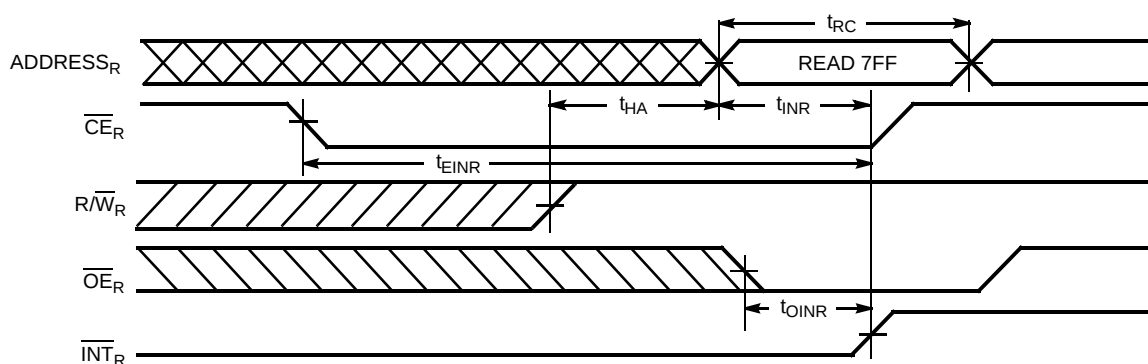


Figure 14. Right Side Sets $\overline{\text{INT}}_L$

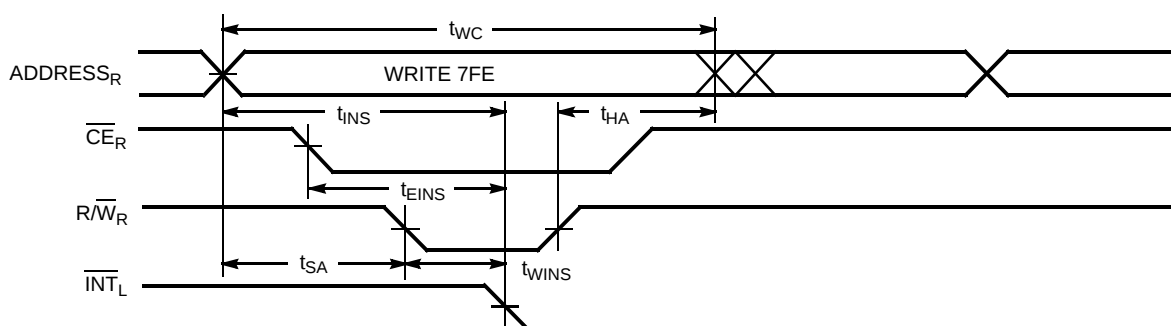


Figure 15. Right Side Clears $\overline{\text{INT}}_L$

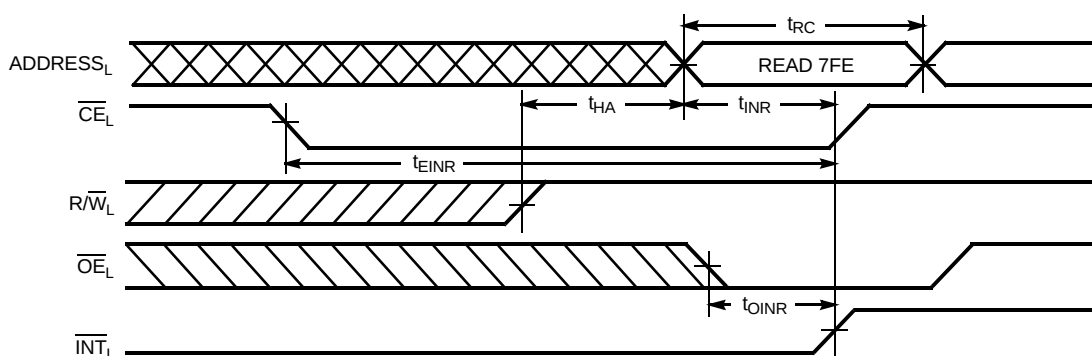
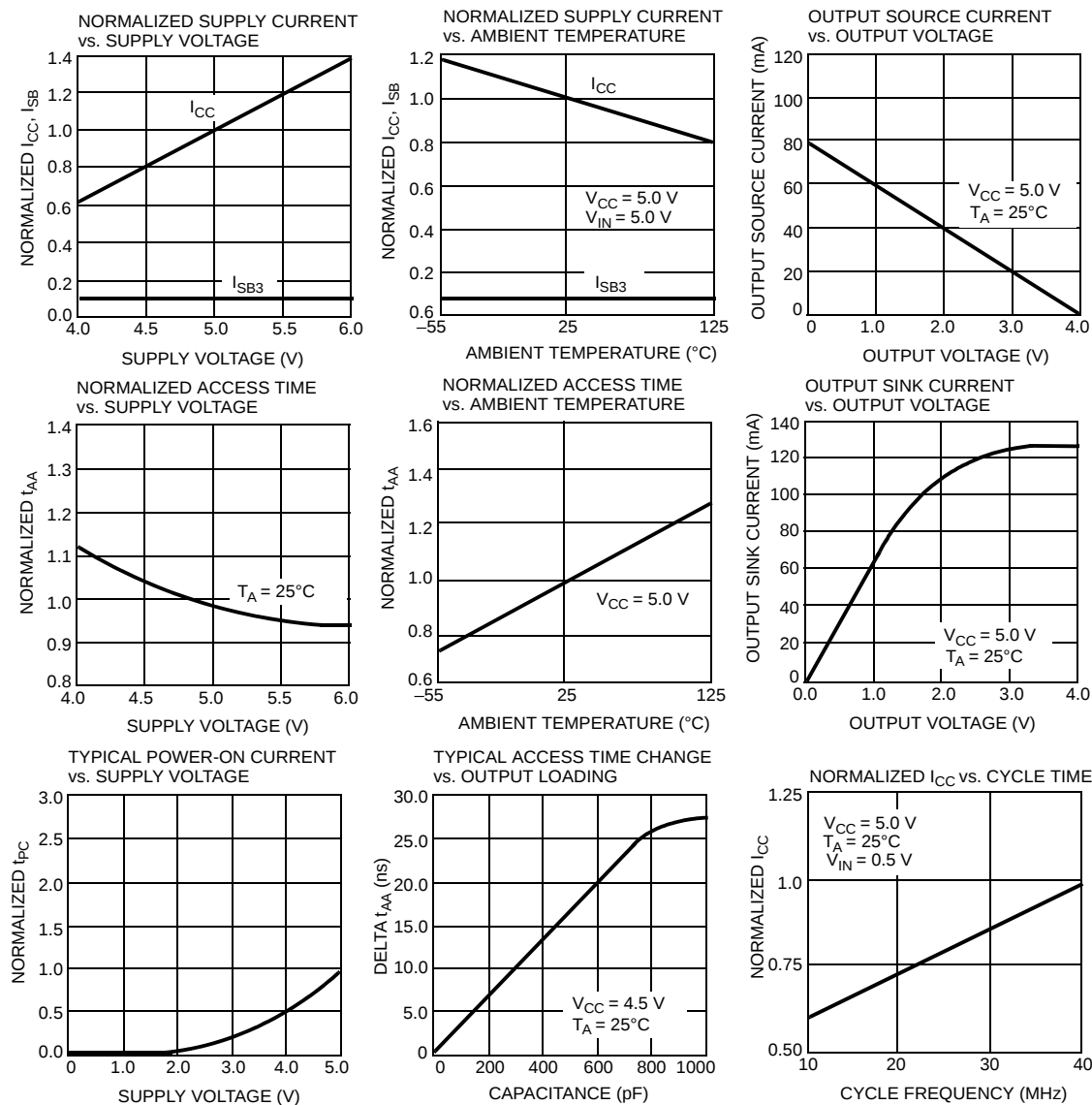


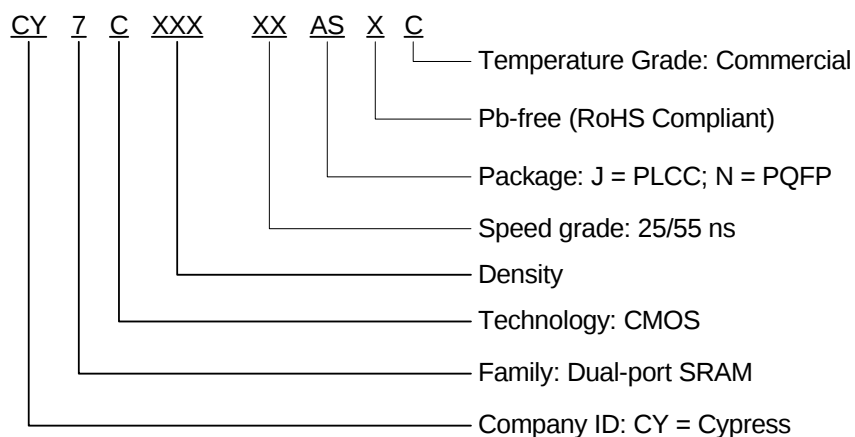
Figure 16. Typical DC and AC Characteristics



Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
25	CY7C136-25JXC	51-85004	52-Pin Plastic Leaded Chip Carrier (Pb-Free)	Commercial
	CY7C136-25NC	51-85042	52-Pin Plastic Quad Flatpack	
	CY7C136-25NXC		52-Pin Plastic Quad Flatpack (Pb-Free)	
	CY7C136-25JXI	51-85004	52-Pin Plastic Leaded Chip Carrier (Pb-Free)	Industrial
55	CY7C136-55JXC	51-85004	52-Pin Plastic Leaded Chip Carrier (Pb-Free)	Commercial
	CY7C136-55NXC	51-85042	52-Pin Plastic Quad Flatpack (Pb-Free)	
	CY7C136A-55JXI	51-85004	52-Pin Plastic Leaded Chip Carrier (Pb-Free)	Industrial
	CY7C136A-55NXI	51-85042	52-Pin Plastic Quad Flatpack (Pb-Free)	
55	CY7C146-55JXC	51-85004	52-Pin Plastic Leaded Chip Carrier (Pb-Free)	Commercial

Ordering Code Definitions



Acronyms

Acronym	Description
CMOS	complementary metal oxide semiconductor
I/O	input/output
PLCC	plastic leaded chip carrier
SRAM	static random access memory
TQFP	thin quad plastic flatpack
TTL	transistion transistor logic

Document Conventions

Units of Measure

Table 1.

Symbol	Unit of Measure
°C	degree Celsius
MHz	mega hertz
μA	microamperes
mA	milliamperes
mV	millivolts
ns	nanoseconds
Ω	ohms
pF	picofarad
V	volts
W	watts

Document History Page

Document Title: CY7C132, CY7C136, CY7C136A, CY7C142, CY7C146 2K x 8 Dual-Port Static RAM Document Number: 38-06031				
Revision	ECN	Submission Date	Orig. of Change	Description of Change
**	110171	10/21/01	SZV	Change from Spec number: 38-06031
*A	128959	09/03/03	JFU	Added CY7C136-55NI to Order Information
*B	236748	See ECN	YDT	Removed cross information from features section
*C	393184	See ECN	YIM	Added Pb-Free Logo Added Pb-Free parts to ordering information: CY7C136-25JXC, CY7C136-25NXC, CY7C136-55JXC, CY7C136-55NXC, CY7C136-55JXI, CY7C136-55NXI, CY7C146-25JXC, CY7C146-55JXC
*D	2623658	12/17/08	VKN/PYRS	Added CY7C136-25JXI part Removed CY7C132/142 from the Ordering information table Removed 48-Pin DIP and 52-Pin Square LCC package from the data sheet
*E	2678221	03/24/2009	VKN/AESA	Added CY7C136A-55JXI, and CY7C136A-55NXI parts.
*F	2896210	03/22/2010	RAME	Updated Ordering Information Updated Package Diagrams
*G	3094400	11/24/10	ADMU	Removed partnumber CY7C136-55JI from the ordering information table. Added ordering code definitions.
*H	3403652	10/14/2011	ADMU	Removed pruned part CY7C136-55JC, CY7C136-55NC from Ordering Information Updated Package Diagrams . Updated template.

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